## Application/Control No. Applicant(s)/Patent Under Reexamination 10/605,202 BAXTER, JOHN F. **Notice of References Cited** Art Unit Examiner Page 1 of 1 2682 Zhiyu Lu **U.S. PATENT DOCUMENTS Document Number** Date Classification Name **Country Code-Number-Kind Code** MM-YYYY US-2002/0183059 12-2002 Noreen et al. 455/427 Α 01-2003 704/270 US-6,505,160 Levy et al. В 07-1985 Martin, III, Robert J. 455/73 C US-4,528,696 US-2002/0155815 10-2002 Richter, Thomas 455/67.1 D US-2003/0050058 03-2003 Walsh et al. 455/426 Ε

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